

Quality Dependence of Bi-layer Graphene on Heating Profile in the Rapid Thermal Processing Method



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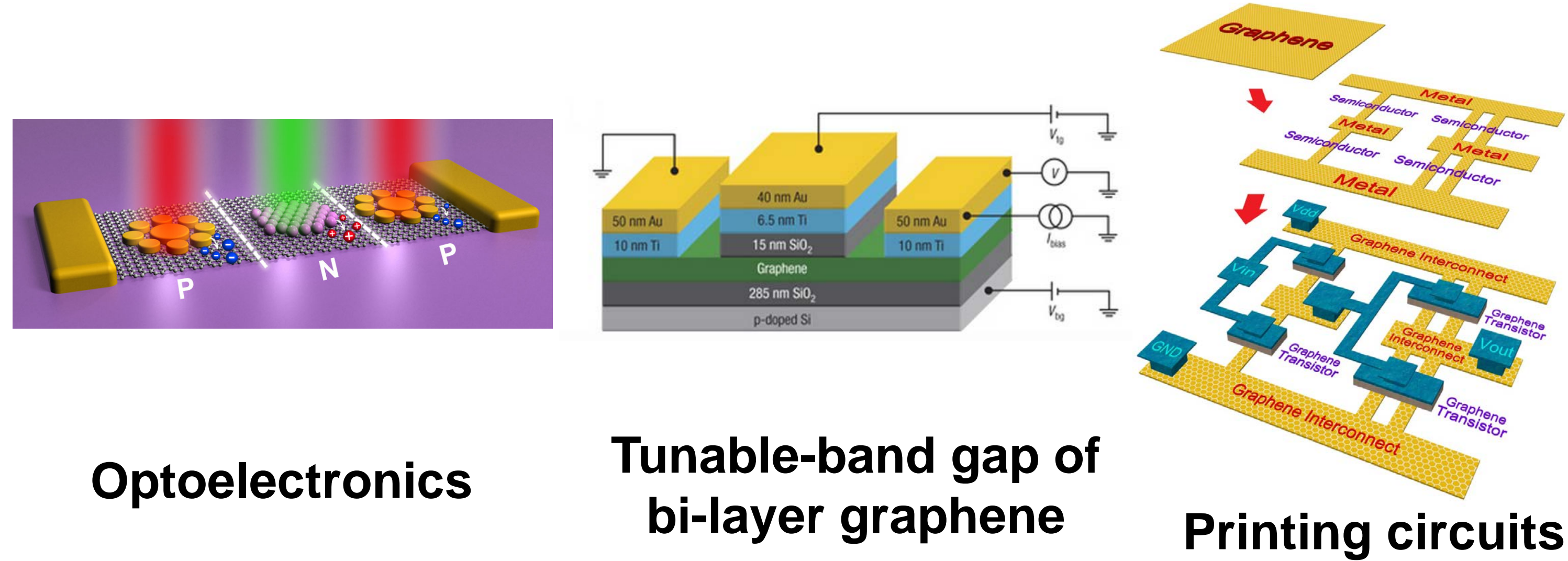
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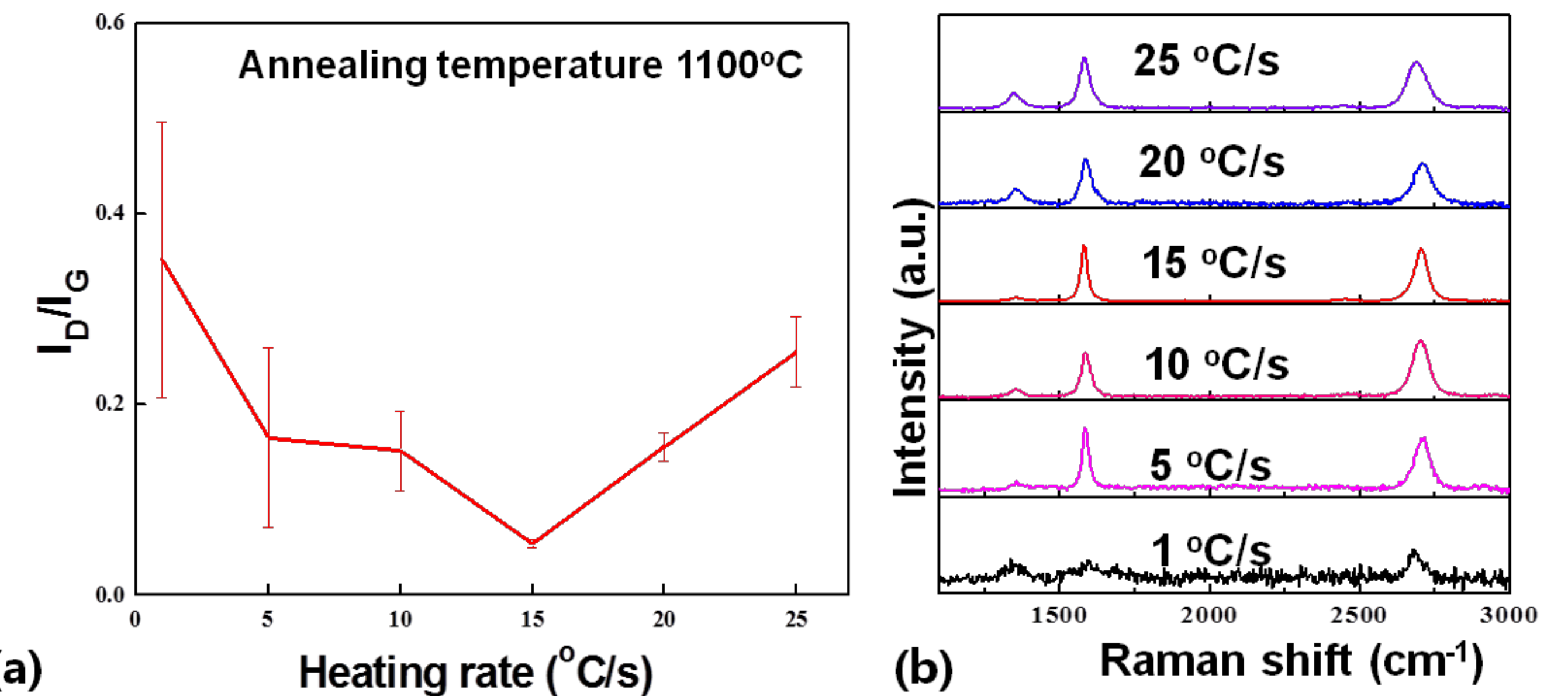
University of
Nebraska-Lincoln

Laser Assisted
Nano-Engineering Lab

Motivations

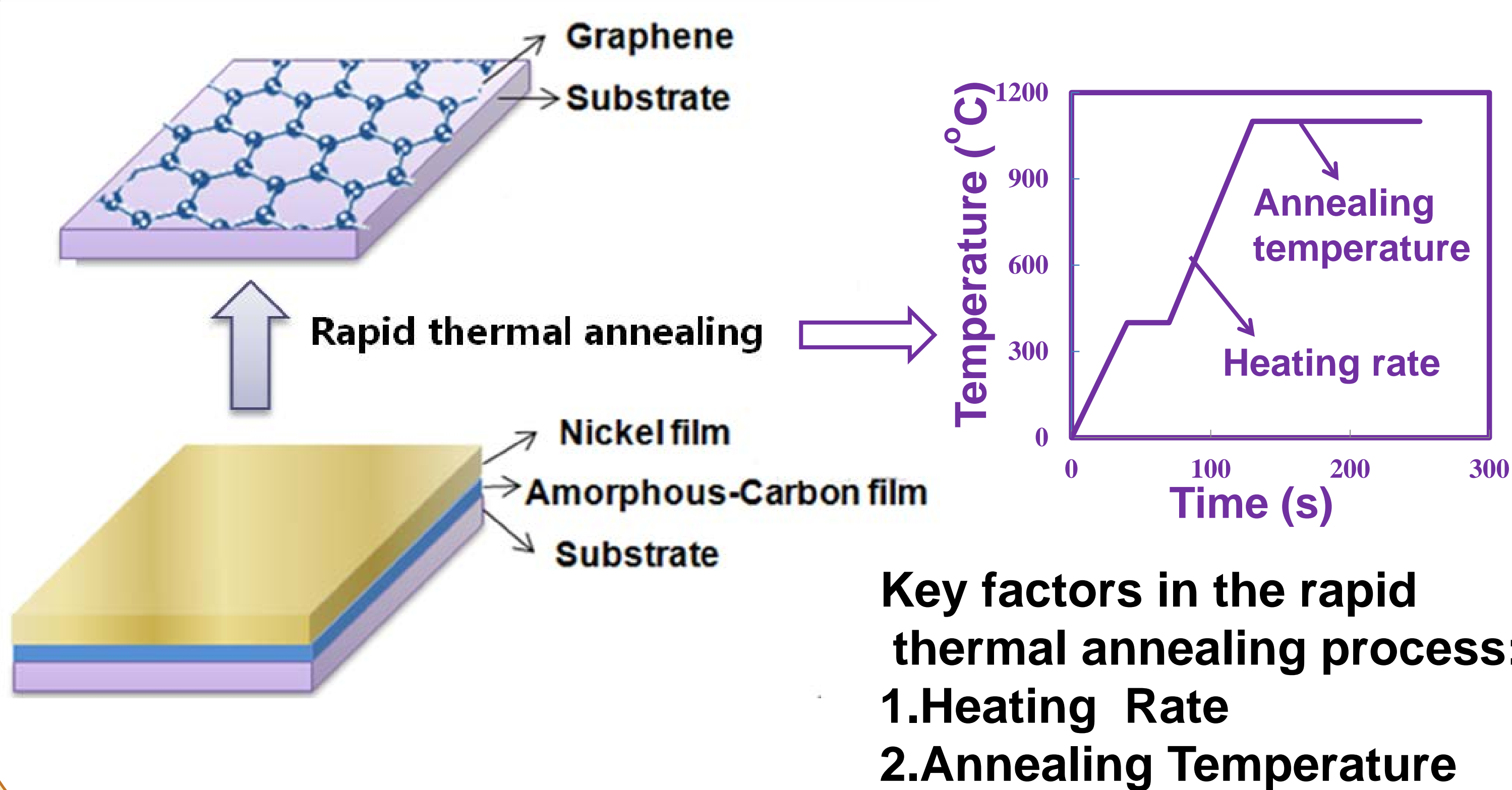


Influence of Heating Rate

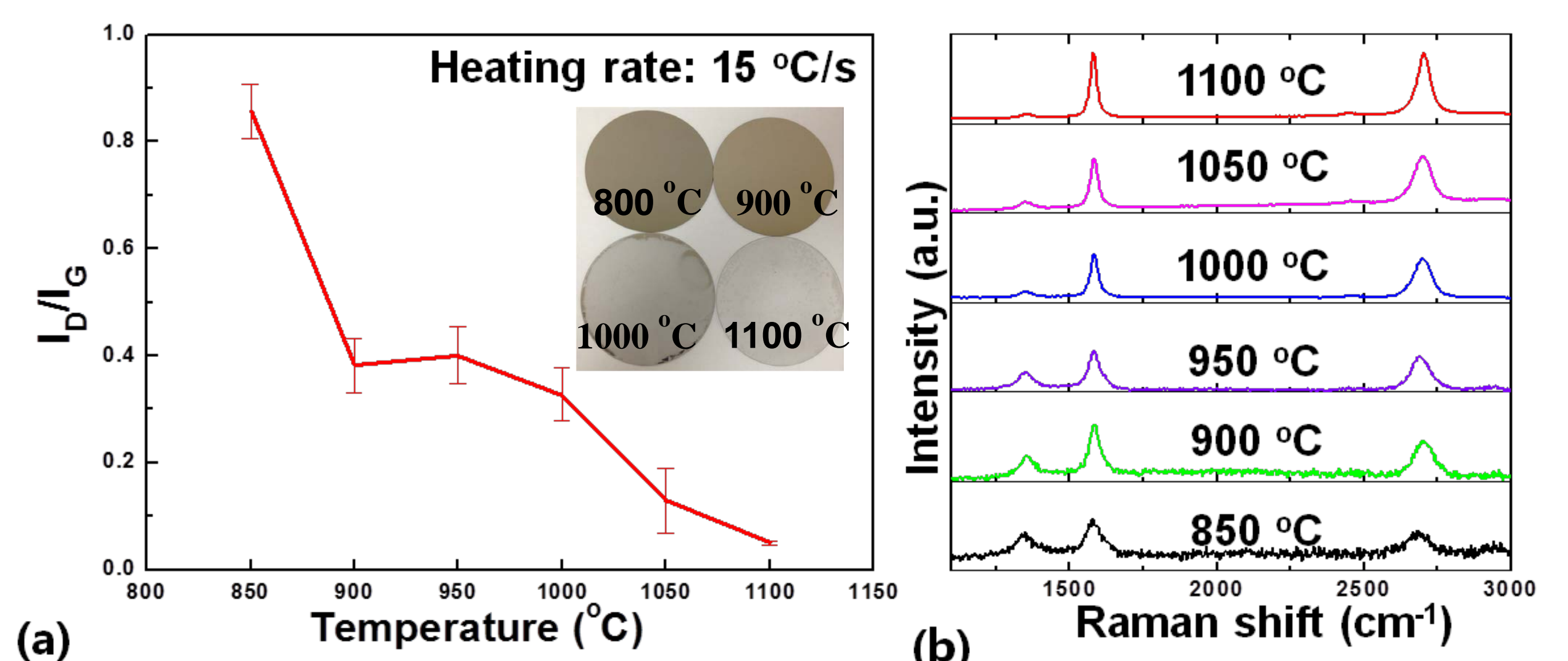


The influence of heating rate when the annealing temperature is set at 1100 °C. (a) D/G ratio plot as a function of heating rate. (b) Corresponding Raman spectra.

Experimental

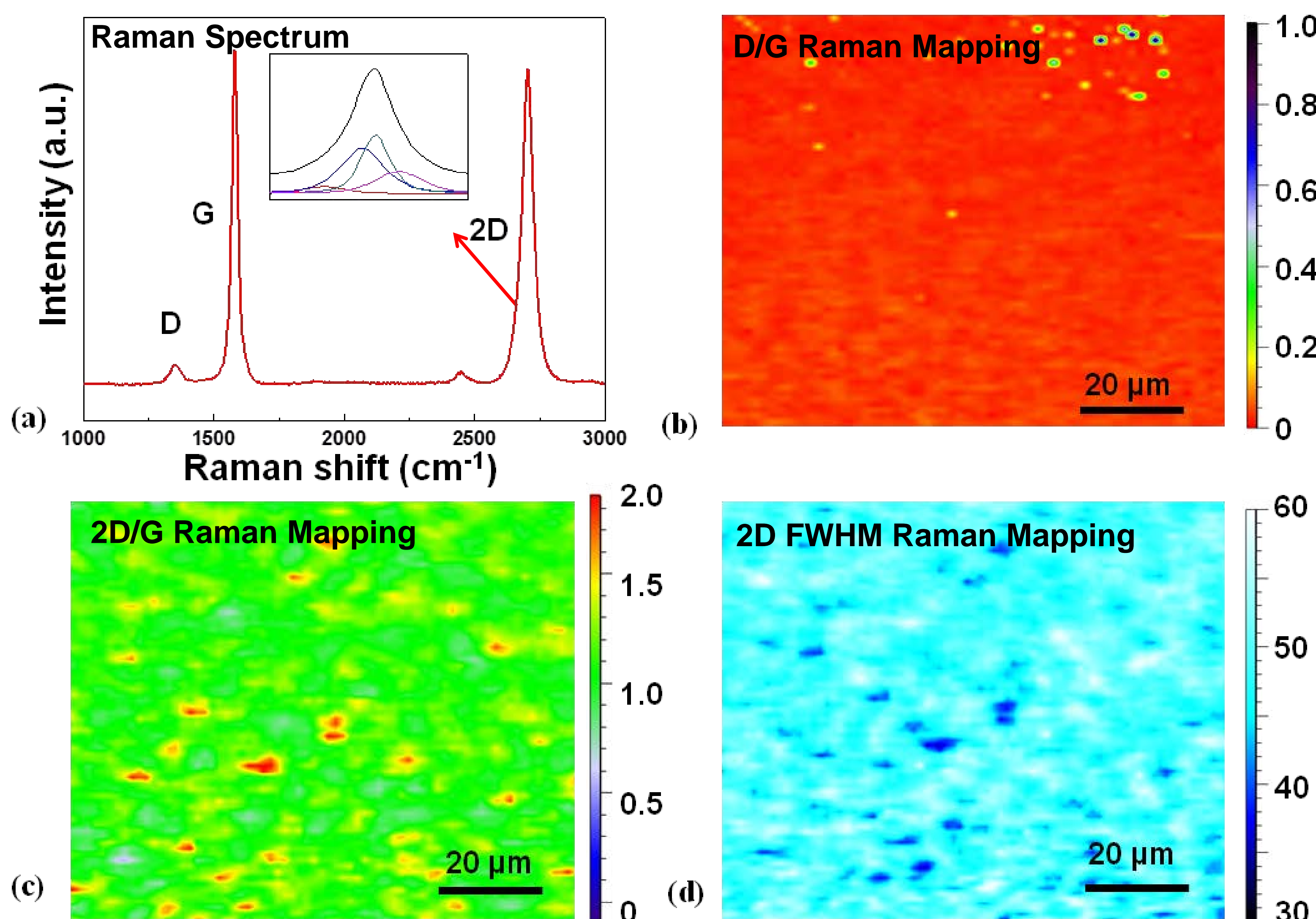


Influence of Annealing Temperature



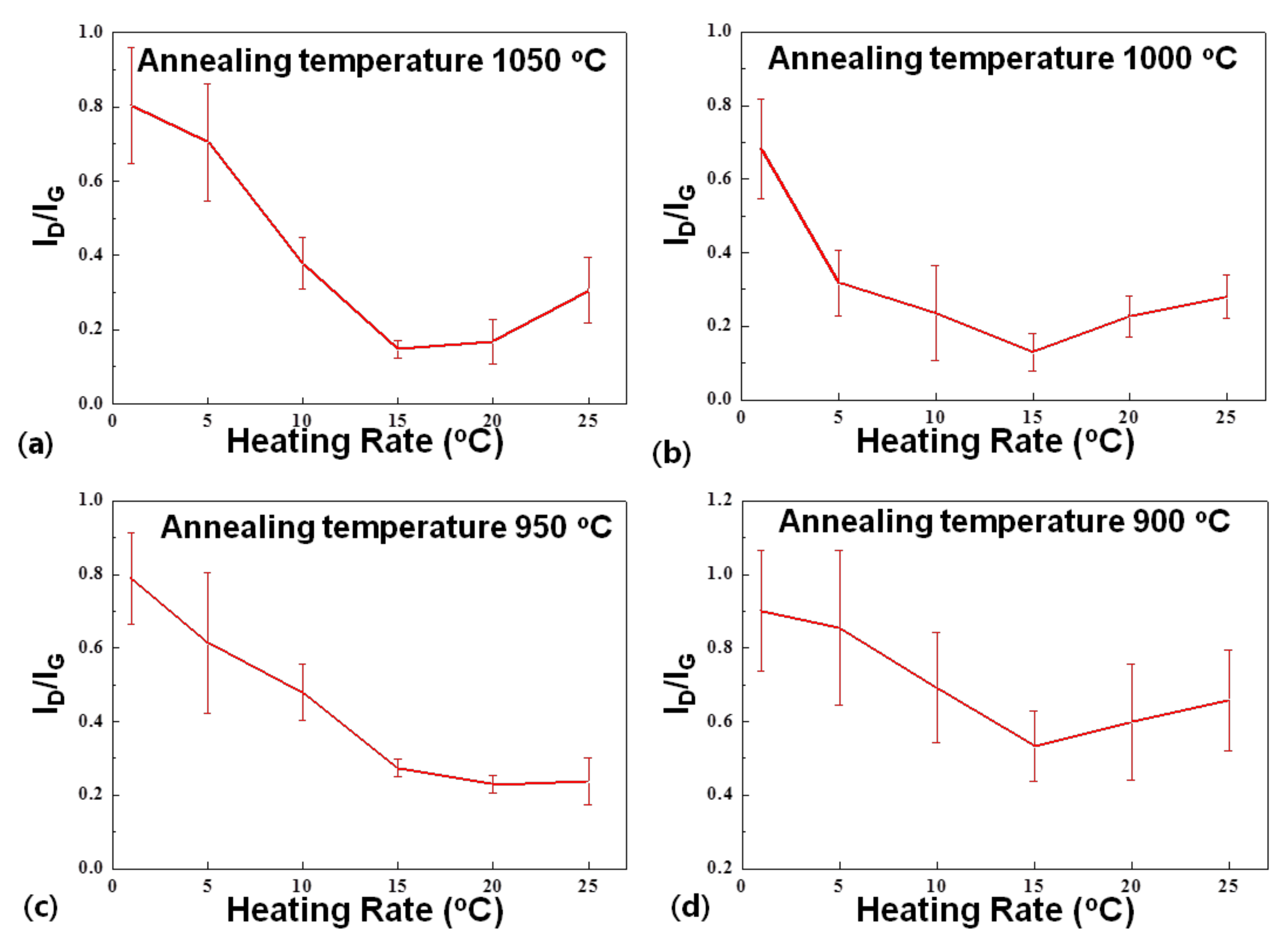
The influence of annealing temperature when the heating rate is set at 15 °C/s. (a) D/G ratio plot as a function of annealing temperature. (b) Corresponding Raman spectra.

Characterization



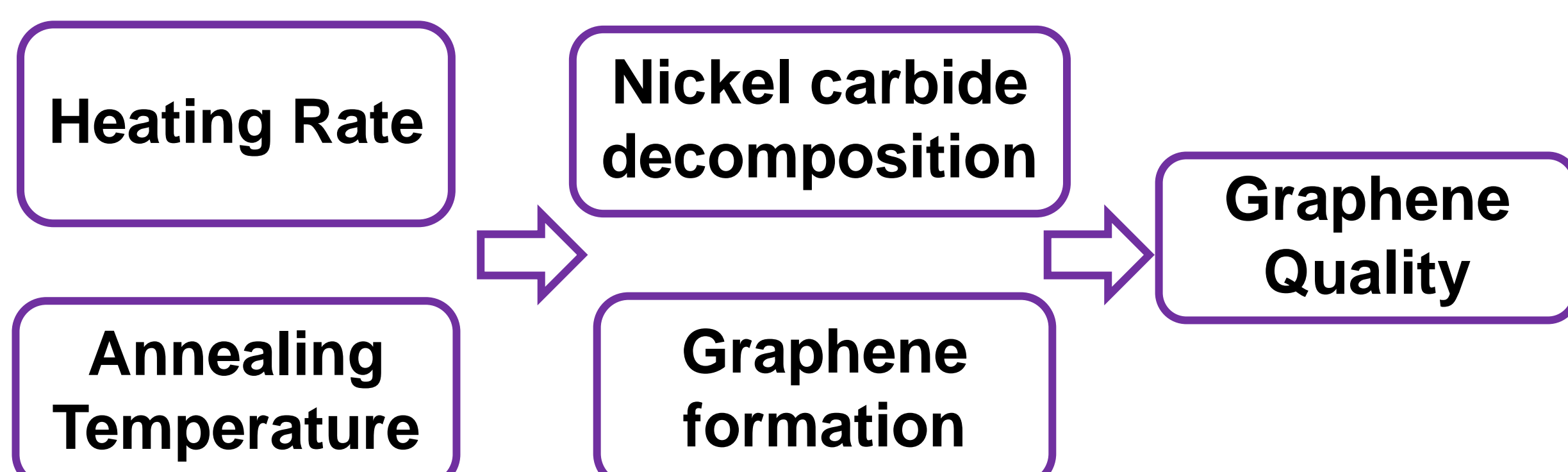
Raman characterization of rapid thermal annealing (RTP) bi-layer graphene.

Control Experiments

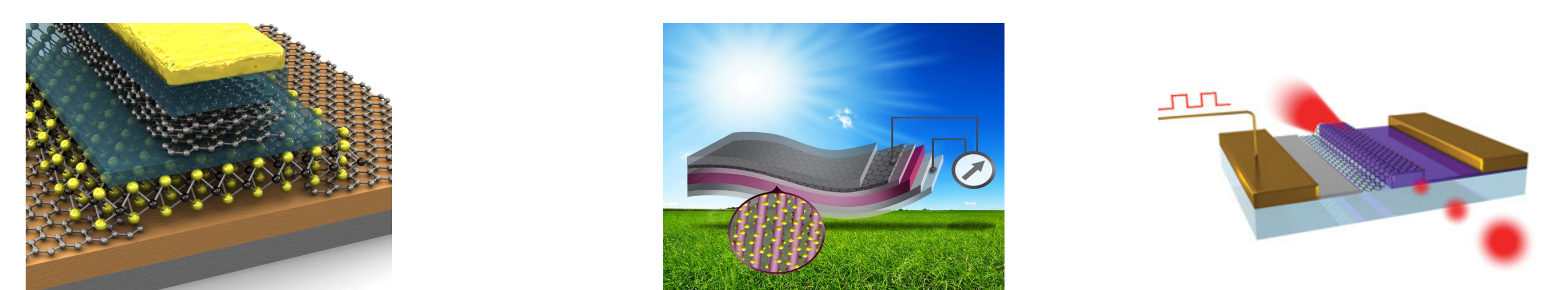


Control experiments of the RTP graphene growth. (a)~(d) D/G ratio plot as a function of heating rate under 1050, 1000, 950, and 900 °C, respectively.

Conclusions



Future Directions



Graphene Heterostructure Graphene Solar Cell Graphene photonics

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